# COMLINEAR<sup>®</sup> CLC2550, CLC4550 Low Power, Low Offset, 2V to 36V Comparators

#### FEATURES

- 2mV input offset voltage
- 25nA input bias current
- ±5nA input offset current
- 0.9mA supply current
- CMIR includes ground
- 200mV output saturation voltage at 4mA
- 2V to 36V single supply voltage range
- ±1V to ±18V dual supply voltage range
- Open collector output

 Differential input voltage range equals the power supply voltage

- CLC2550: improved replacement for industry standard LM393
- CLC4550: Improved replacement for industry standard LM339
- CLC2550: Pb-free SOIC-8
- CLC4550: Pb-free SOIC-14

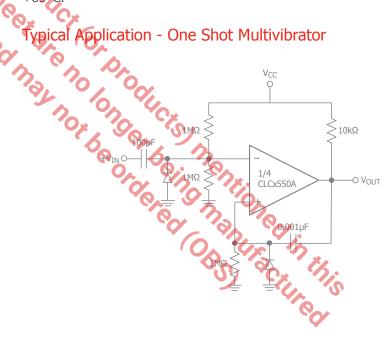
#### **APPLICATIONS**

- Battery charger
- Cordless telephone
- Switching power supply
- DC-DC module
- PC motherboard
- Widerange VCO
- Squarewave and time delay generators
- MOS clock timers
- High voltage digital logic gates
- Multivibrators

### **General Description**

The COMLINEAR CLC2550 (dual) and CLC4550 (guad) are precision voltage comparators with a typical offset of 2mV and high gain (200V/mV). These comparators also offer an input common-mode voltage range that includes ground.

The COMLINEAR CLC2550, and CLC4550 operate from a wide supply voltage range of  $\pm 1V$  to  $\pm 18V$ , or from a single supply range of 2V to 36V. These comparators are available in Pb-free, RoHS compliant SOIC-8 and SOIC-14 packages. They operate over the industrial temperature range of -40°C to +85°C



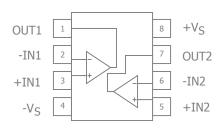
### Ordering Information

| Part Number   | Package | Pb-Free | RoHS Compliant | Operating Temperature Range | Packaging Method |
|---------------|---------|---------|----------------|-----------------------------|------------------|
| CLC2550ISO8X  | SOIC-8  | Yes     | Yes            | -40°C to +85°C              | Reel             |
| CLC4550ISO14X | SOIC-14 | Yes     | Yes            | -40°C to +85°C              | Reel             |

Moisture sensitivity level for all parts is MSL-1.



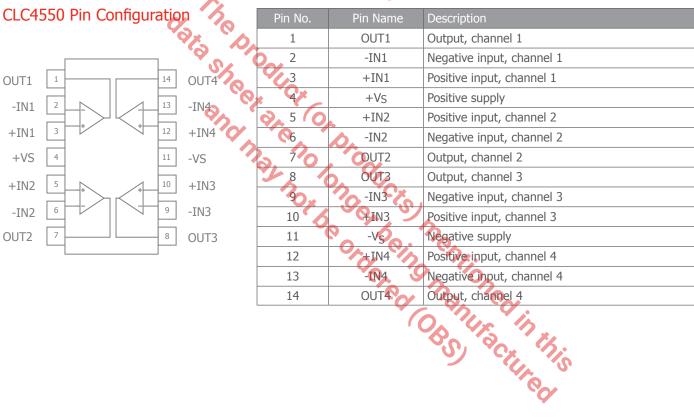
### CLC2550 Pin Configuration



### CLC2550 Pin Configuration

| Pin No. | Pin Name        | Description               |  |
|---------|-----------------|---------------------------|--|
| 1       | OUT1            | Output, channel 1         |  |
| 2       | -IN1            | Negative input, channel 1 |  |
| 3       | +IN1            | Positive input, channel 1 |  |
| 4       | -V <sub>S</sub> | Negative supply           |  |
| 5       | +IN2            | Positive input, channel 2 |  |
| 6       | -IN2            | Negative input, channel 2 |  |
| 7       | OUT2            | Output, channel 2         |  |
| 8       | +V <sub>S</sub> | Positive supply           |  |

### CLC4550 Pin Configuration



### Absolute Maximum Ratings

The safety of the device is not guaranteed when it is operated above the "Absolute Maximum Ratings". The device should not be operated at these "absolute" limits. Adhere to the "Recommended Operating Conditions" for proper device function. The information contained in the Electrical Characteristics tables and Typical Performance plots reflect the operating conditions noted on the tables and plots.

| Min   | Max   | Unit  |
|-------|-------|---|
| 0     | 40    | V   |
|       | 40    | V   |
| -0.3  | 40    | V   |
|       | 50    | mA  |
| Conti | nuous |   |
|       | 660   | mW  |
|       | 890   | mW  |
|       | -0.3  | 0         40           40         40           -0.3         40           50         50           Continuous         660 |

Notes:

1. This input current will only exist when the voltage at any of the input leads is driven negative. It is due to the collector-base junction of the input PNP transistors be-coming forward biased and thereby acting as input dide clamps. In addition to this diode action, there is also lateral NPN parasitic transistor action on the IC chip. This transistor action can cause the output voltages of the comparators to go to the V+ voltage level (or to ground for a large overdrive) for the time duration that an input is driven negative. This is not destructive and normal output states will re establish when the input voltage, which was negative, again returns to a value greater than -0.3 V<sub>DC</sub> (at 25°C). nd me no pro

### **Reliability Information**

| Parameter   | Min | Тур | Max | Unit |  |
|---|-----|-----|-----|------|--|
| Junction Temperature  | 0   |     | 150 | °C   |  |
| Storage Temperature Range   | 65  |     | 150 | °C   |  |
| Lead Temperature (Soldering, 10s)   | 6   | 1   | 260 | °C   |  |
| Package Thermal Resistance  |     |     |     |      |  |
| SOIC-8  |     | 100 |     | °C/W |  |
| SOIC-14   |     | 88  | 2   | °C/W |  |
| Notes:<br>Package thermal resistance (θ <sub>JA</sub> ), JDEC standard, multi-layer test boards, still air.<br>Recommended Operating Conditions |     |     |     |      |  |
| Parameter   | Min | Typ | Max | Unit |  |

| Parameter                   | Min    | Тур | Max      | Unit |
|-----------------------------|--------|-----|----------|------|
| Operating Temperature Range | -40    |     | +85 📿    | °C   |
| Supply Voltage Range        | 2 (±1) |     | 36 (±18) | V    |

### **Electrical Characteristics**

 $T_A = 25^{\circ}C$  (if **bold**,  $T_A = -40$  to  $+85^{\circ}C$ ),  $V_s = +5V$ ,  $-V_s = GND$  unless otherwise noted.

| Symbol  | Parameter  | Conditions   | Min         | Тур      | Max                      | Units |
|---|--|--|-------------|----------|--------------------------|-------|
| DC Perform  | ance   |  |             |          |                          |       |
|   |  |  |             | 2        | 5                        | mV    |
| V <sub>IO</sub> Input Offset Voltage  | $V_{OUT} = 1.4V$ , $R_S = 0\Omega$ , $V_S = 5V$ to 30V |  |             | 7        | mV                       |       |
| I <sub>b</sub> Input Bias Current   | $\lambda = 0 \lambda$                                  |  | 25          | 250      | nA                       |       |
|   | $V_{CM} = 0V$  |  |             | 400      | nA                       |       |
| I <sub>OS</sub> Input Offset Current  | $V_{CM} = 0V$  |  | 5           | 50       | nA                       |       |
|   |  |  |             | 200      | nA                       |       |
| CMIR  | Common Mode Input Range (3)                            | +V <sub>S</sub> = 30V  | 0           |          | +V <sub>S</sub><br>- 1.5 | V     |
| VG  | Voltage Gain   | $+V_{S} = 15V, R_{L} = \ge 15k\Omega, V_{OUT} = 1V \text{ to } 11V$          | 50          | 200      |                          | V/mV  |
|   | CI Do  | $P = \infty + V = 20V$   |             | 0.7      | 1.7                      | mA    |
|   | Supply Current CLC2EE                                  | $R_L = \infty, +V_S = 30V$   |             |          | 3.0                      | mA    |
|   | Supply current, CLC2550                                |  |             | 0.6      | 1.0                      | mA    |
| CMIR       Common Mode Input Range (3)         VG       Voltage Gain         Is       Supply Current, CLC2550         Supply Current, CLC4550       Supply Current, CLC4550         Time Domain Response       Large Signal Response Time | S S  | $R_{L} = \omega, + v_{S} = 5v$   |             |          | 2.0                      | mA    |
|   | (Q)  |  |             | 1.2      | 2.5                      | mA    |
|   | Supply Current CLC4550                                 | $T_{V} = \omega, \pm v_{S} = 50V$  |             |          | 3.0                      | mA    |
|   | $P = \alpha \pm V_{c} = 5V$                            |  | 0.9         | 2.0      | mA                       |       |
| <b>/</b>  |  |  |             |          | 3.0                      | mA    |
| Time Doma   | in Response  |  |             | 1        | 1                        |       |
| t <sub>RLS</sub>  | Large Signal Response Time                             | $V_{IN} = 776$ logic swing, $V_{REF} = 1.4V$ , $V_{RL} = 5V$ , $R_L = 5.1kQ$ |             | 200      |                          | ns    |
|   |  | $V_{RL} = 5V, R_L = 5.1 k\Omega, 5mV$ overdrive                              |             | 1.3      |                          | μs    |
| t <sub>R</sub> Response Time  | Response Time  | $V_{RL} = 5V_{RL} = 5.1k\Omega_{r}$ 10mV overdrive                           |             | 0.9      |                          | μs    |
|   |  | $V_{RL} = 5V, R_{CT} = 5.1k\Omega, 15mV$ overdrive                           |             | 0.8      |                          | μs    |
| Dutput Cha  | racteristics   |  |             | 1        | r                        | r     |
| I <sub>SINK</sub>   | Output Sink Current                                    | $V_{IN+} = 0V, V_{IN-} = 1V, V_{OUT} = 1.5V$                                 | 6.0         | 16       |                          | mA    |
| I <sub>LEAK</sub> Output Leal   | Output Leakage Current                                 | $V_{IN+} = 1V, V_{IN-} = 0V, V_{OV} = 5V$                                    |             | 0.1      |                          | nA    |
| *LEAK   |  | $V_{IN+} = 1V, V_{IN-} = 0V, V_{OUT} = 30V$                                  | <u> </u>    |          | 1                        | μA    |
| V <sub>SAT</sub>  | Saturation Voltage                                     | $V_{IN+} = 0V, V_{IN-} = 1V, I_{SINK} \le 4mA$                               | <u>`?</u> , | 200      | 400                      | mV    |
| V SAT Sau   | Saturation voltage                                     | • IN+ - OA, AIN TA, TZINK - III  | 0           | <b>.</b> | 500                      | mV    |

#### Notes:

1. 100% tested at 25°C

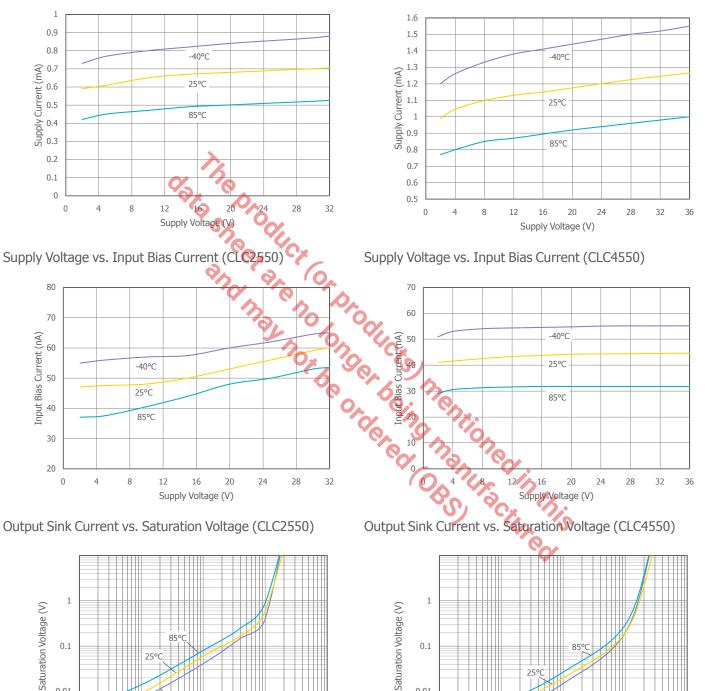
2. Limits over the full temperature range are guaranteed by design.

3. The input common mode voltage of either input signal voltage should be kept > 0.3V at 25°C. The upper end of the common-mode voltage range is  $+V_S - 1.5V$  at 25°C, but either or both inputs can go to +18V without damages, independent of the magnitude of  $V_S$ .

### **Typical Performance Characteristics**

 $T_A = 25^{\circ}C$ ,  $V_s = +5V$ ,  $-V_s = GND$  unless otherwise noted.

Supply Current vs. Supply Voltage (CLC2550)



Supply Current vs. Supply Voltage (CLC4550)

25°C

1

Output Sink Current (mA)

10

0.1

0.01

0.001

0.01

0.1

1

Output Sink Current (mA)

10

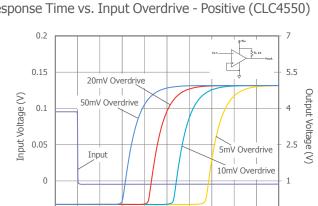
0.01

0.001 0.01 0.2

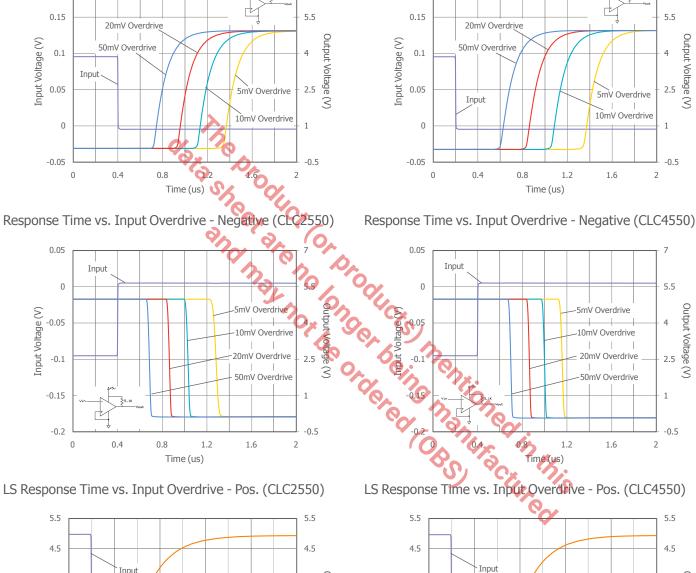
### **Typical Performance Characteristics**

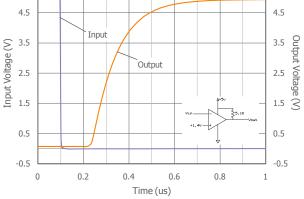
 $T_A = 25^{\circ}C$ ,  $V_s = +5V$ ,  $-V_s = GND$  unless otherwise noted.

Response Time vs. Input Overdrive - Positive (CLC2550)

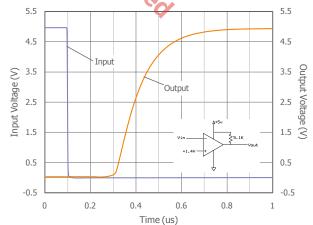


Response Time vs. Input Overdrive - Positive (CLC4550)







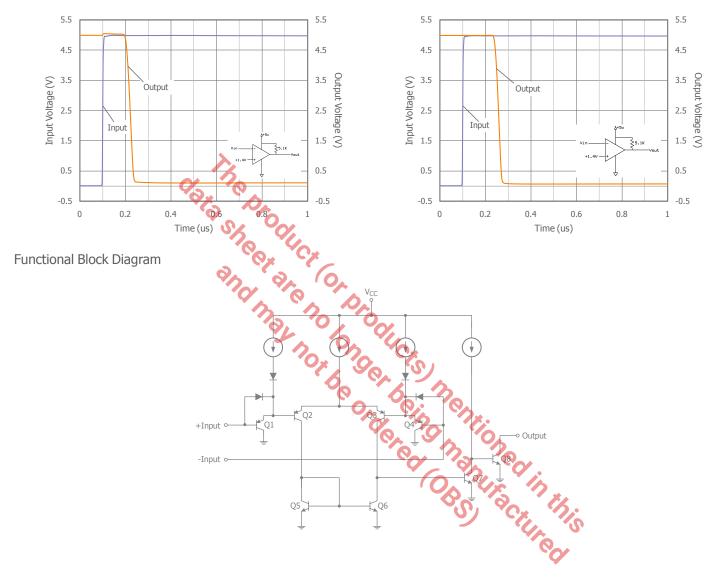


### Typical Performance Characteristics - Continued

 $T_A = 25^{\circ}C$ ,  $V_s = +5V$ ,  $-V_s = GND$  unless otherwise noted.

LS Response Time vs. Input Overdrive - Neg. (CLC2550)

LS Response Time vs. Input Overdrive - Neg. (CLC4550)



### **Application Information**

The CLCx550 series are high gain, wide bandwidth devices which, like most comparators, can easily oscillate if the output lead is inadvertently allowed to capacitively couple to the inputs via stray capacitance. This shows up only during the output voltage transition intervals as the comparator changes states. Power supply bypassing is not required to solve this problem. Standard PC board layout is helpful as it reduces stray input-output coupling. Reducing this input resistors to  $< 10k\Omega$  reduces the feedback signal levels and finally, adding even a small amount (1 to 10mV) of positive feedback (hysteresis) causes such a rapid transition that oscillations due to stray feedback are not possible. Simply socketing the IC and attaching resistors to the pins will cause input output oscillations during the small transition intervals unless hysteresis is used. If the input signal is a pulse waveform, with relatively fast rise and fall times, hysteresis is not required.

All pins of any unused comparators should be tied to the negative supply. The bias network of the CLCx550 series establishes a drain current which is independent of the magnitude of the power supply voltage over the range of 2V DC to 30V DC. It is usually unnecessary to use a bypass capacitor across the power supply line.

The differential input voltage may be larger than V+ without damaging the device. Protection should be provided to prevent the input voltages from going negative more than -0.3V DC (at 25°C). An input clamp diode can be used as shown in the applications section.

The output of the CLCx550 series is the uncommitted collector of a grounded-emitter NPN output transistor. Many collectors can be tied together to provide an output OR'ing function. An output pull-up resistor can be connected to any available power supply voltage within the permitted supply voltage range and there is no restriction on this voltage due to the magnitude of the voltage which is applied to the V+ terminal of the CLCx550 package. The output can also be used as a simple SPST switch to ground (when a pull-up resistor is not used). The amount of current which the output device can sink is limited by the drive available (which is independent of V+) and the  $\beta$ of this device. When the maximum current limit is reached (approximately 16 mA), the output transistor will come out of saturation and the output voltage will rise very rapidly. The output saturation voltage is limited by the approximately  $60\Omega$  RSAT of the output transistor. The low offset voltage of the output transistor (1 mV) allows the output to clamp essentially to ground level for small load currents.

#### Layout Considerations

General layout and supply bypassing play major roles in high frequency performance. Exar has evaluation boards to use as a guide for high frequency layout and as an aid in device testing and characterization. Follow the steps below as a basis for high frequency layout:

 $\bullet$  Include 6.8µF and 0.1µF ceramic capacitors for power supply decoupling

- $\bullet$  Place the 6.8  $\!\mu\text{F}$  capacitor within 0.75 inches of the power pin
- $\bullet$  Place the  $0.1 \mu \text{F}$  capacitor within 0.1 inches of the power pin
- Remove the ground plane under and around the part, especially near the input and output pins to reduce parasitic capacitance
- Minimize all trace lengths to reduce series inductances

Refer to the evaluation board layouts below for more information.

### Evaluation Board Information

The following evaluation boards are available to aid in the testing and layout of these devices:

| Evaluation Board | Products |
|------------------|----------|
| CEB006           | CLC2550  |
| CEB018           | CLC4550  |
|                  | 6        |

### **Evaluation Board Schematics**

Evaluation board schematics and layouts are shown in Figures 9-14. These evaluation boards are built for dualsupply operation. Follow these steps to use the board in a single-supply application:

1. Short -Vs to ground.

2. Use C3 and C4, if the  $-V_S$  pin of the amplifier is not directly connected to the ground plane.

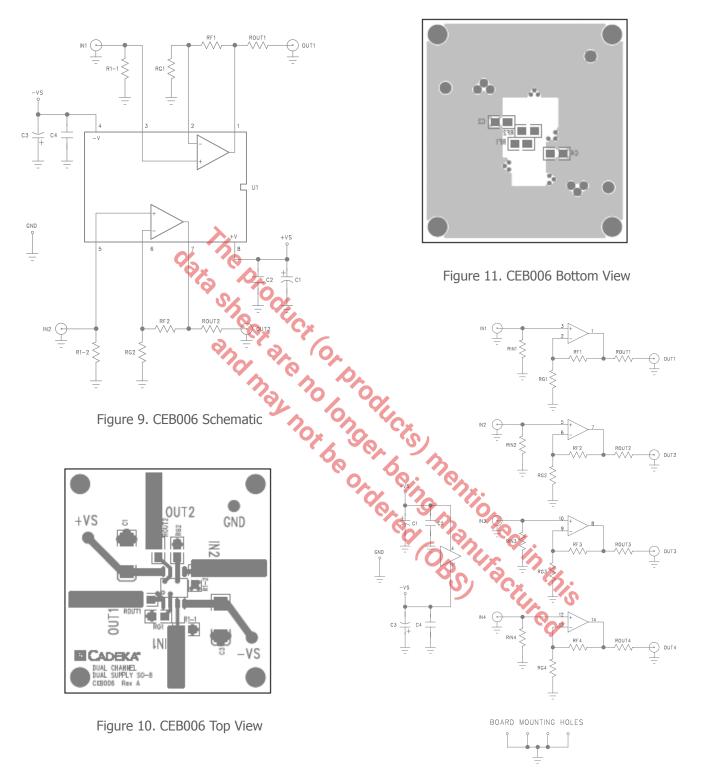


Figure 12. CEB018 Schematic

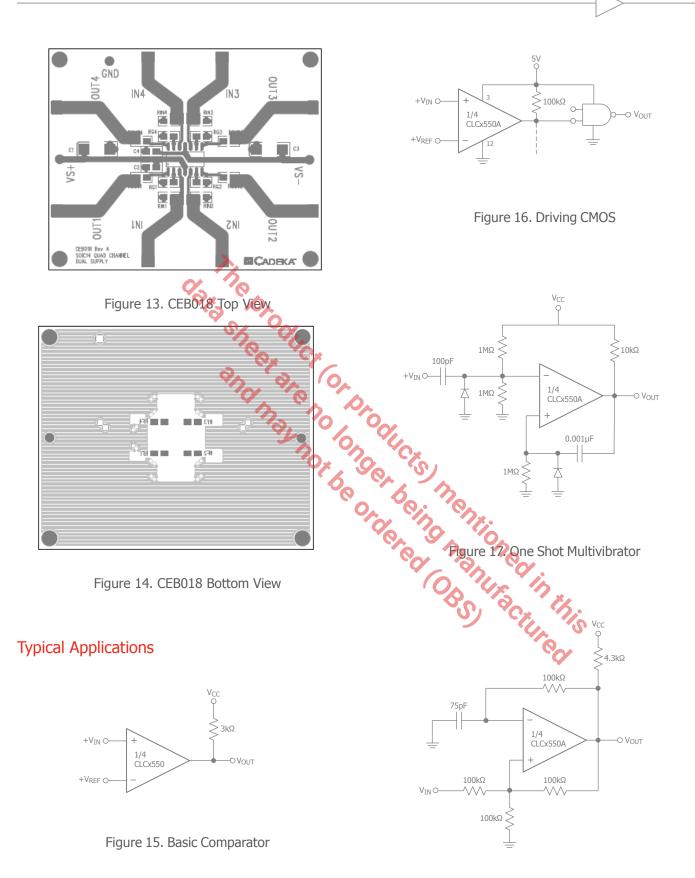
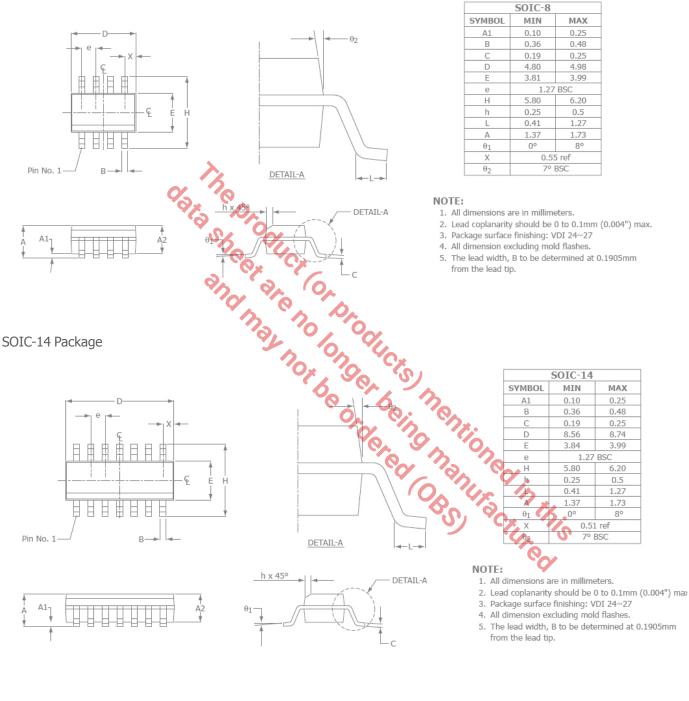


Figure 18. Squarewave Oscillator

### **Mechanical Dimensions**

SOIC-8 Package



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